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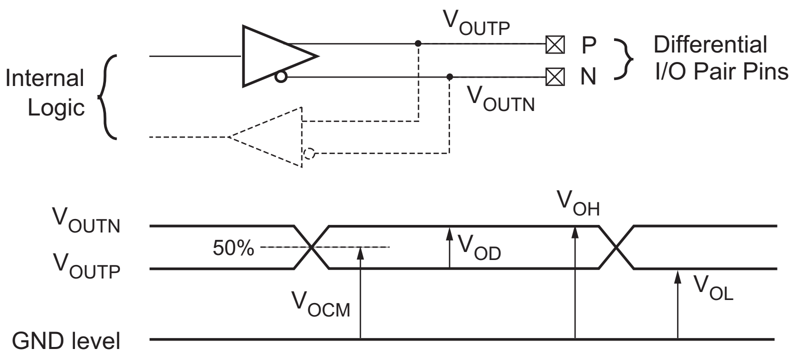
The versatility of Embedded - FPGAs makes them indispensable in numerous fields. In telecommunications,

Details	
Product Status	Active
Number of LABs/CLBs	896
Number of Logic Elements/Cells	8064
Total RAM Bits	368640
Number of I/O	195
Number of Gates	400000
Voltage - Supply	1.14V ~ 1.26V
Mounting Type	Surface Mount
Operating Temperature	-40°C ~ 100°C (TJ)
Package / Case	256-LBGA
Supplier Device Package	256-FTBGA (17x17)
Purchase URL	https://www.e-xfl.com/product-detail/xilinx/xc3s400a-4ftg256i

Differential Output Pairs



$$V_{OCM} = \text{Output common mode voltage} = \frac{V_{OUTP} + V_{OUTN}}{2}$$

$$V_{OD} = \text{Output differential voltage} = \left|V_{OUTP} - V_{OUTN}\right|$$

$$V_{OH} = \text{Output voltage indicating a High logic level}$$

$$V_{OL} = \text{Output voltage indicating a Low logic level}$$

DS529-3_11_012907

Figure 5: **Differential Output Voltages**

Table 14: **DC Characteristics of User I/Os Using Differential Signal Standards**

IOSTANDARD Attribute	V_{OD}			V_{OCM}			V_{OH}	V_{OL}
	Min (mV)	Typ (mV)	Max (mV)	Min (V)	Typ (V)	Max (V)	Min (V)	Max (V)
LVDS_25	247	350	454	1.125	–	1.375	–	–
LVDS_33	247	350	454	1.125	–	1.375	–	–
BLVDS_25	240	350	460	–	1.30	–	–	–
MINI_LVDS_25	300	–	600	1.0	–	1.4	–	–
MINI_LVDS_33	300	–	600	1.0	–	1.4	–	–
RSDS_25	100	–	400	1.0	–	1.4	–	–
RSDS_33	100	–	400	1.0	–	1.4	–	–
TMDS_33	400	–	800	$V_{CCO} – 0.405$	–	$V_{CCO} – 0.190$	–	–
PPDS_25	100	–	400	0.5	0.8	1.4	–	–
PPDS_33	100	–	400	0.5	0.8	1.4	–	–
DIFF_HSTL_I_18	–	–	–	–	–	–	$V_{CCO} – 0.4$	0.4
DIFF_HSTL_II_18	–	–	–	–	–	–	$V_{CCO} – 0.4$	0.4
DIFF_HSTL_III_18	–	–	–	–	–	–	$V_{CCO} – 0.4$	0.4
DIFF_HSTL_I	–	–	–	–	–	–	$V_{CCO} – 0.4$	0.4
DIFF_HSTL_III	–	–	–	–	–	–	$V_{CCO} – 0.4$	0.4
DIFF_SSTL18_I	–	–	–	–	–	–	$V_{TT} + 0.475$	$V_{TT} – 0.475$
DIFF_SSTL18_II	–	–	–	–	–	–	$V_{TT} + 0.603$	$V_{TT} – 0.603$
DIFF_SSTL2_I	–	–	–	–	–	–	$V_{TT} + 0.61$	$V_{TT} – 0.61$
DIFF_SSTL2_II	–	–	–	–	–	–	$V_{TT} + 0.81$	$V_{TT} – 0.81$
DIFF_SSTL3_I	–	–	–	–	–	–	$V_{TT} + 0.6$	$V_{TT} – 0.6$
DIFF_SSTL3_II	–	–	–	–	–	–	$V_{TT} + 0.8$	$V_{TT} – 0.8$

Notes:

1. The numbers in this table are based on the conditions set forth in Table 8 and Table 13.
2. See "External Termination Requirements for Differential I/O," page 20.
3. Output voltage measurements for all differential standards are made with a termination resistor (R_T) of 100Ω across the N and P pins of the differential signal pair.
4. At any given time, no more than two of the following differential output standards can be assigned to an I/O bank: LVDS_25, RSDS_25, MINI_LVDS_25, PPDS_25 when V_{CCO}=2.5V, or LVDS_33, RSDS_33, MINI_LVDS_33, TMDS_33, PPDS_33 when V_{CCO} = 3.3V

I/O Timing

Pin-to-Pin Clock-to-Output Times

Table 18: **Pin-to-Pin Clock-to-Output Times for the IOB Output Path**

Symbol	Description	Conditions	Device	Speed Grade		Units
				-5	-4	
				Max	Max	
Clock-to-Output Times						
$T_{ICKOFDCM}$	When reading from the Output Flip-Flop (OFF), the time from the active transition on the Global Clock pin to data appearing at the Output pin. The DCM is in use.	LVCMOS25(2), 12mA output drive, Fast slew rate, with DCM(3)	XC3S50A	3.18	3.42	ns
			XC3S200A	3.21	3.27	ns
			XC3S400A	2.97	3.33	ns
			XC3S700A	3.39	3.50	ns
			XC3S1400A	3.51	3.99	ns
T_{ICKOF}	When reading from OFF, the time from the active transition on the Global Clock pin to data appearing at the Output pin. The DCM is not in use.	LVCMOS25(2), 12mA output drive, Fast slew rate, without DCM	XC3S50A	4.59	5.02	ns
			XC3S200A	4.88	5.24	ns
			XC3S400A	4.68	5.12	ns
			XC3S700A	4.97	5.34	ns
			XC3S1400A	5.06	5.69	ns

Notes:

1. The numbers in this table are tested using the methodology presented in Table 27 and are based on the operating conditions set forth in Table 8 and Table 11.
2. This clock-to-output time requires adjustment whenever a signal standard other than LVCMOS25 is assigned to the Global Clock Input or a standard other than LVCMOS25 with 12 mA drive and Fast slew rate is assigned to the data Output. If the former is true, *add* the appropriate Input adjustment from Table 23. If the latter is true, *add* the appropriate Output adjustment from Table 26.
3. DCM output jitter is included in all measurements.

Pin-to-Pin Setup and Hold Times

Table 19: **Pin-to-Pin Setup and Hold Times for the IOB Input Path (System Synchronous)**

Symbol	Description	Conditions	Device	Speed Grade -5 Min	Speed Grade -4 Min	Units
Setup Times						
T_{PSDCM}	When writing to the Input Flip-Flop (IFF), the time from the setup of data at the Input pin to the active transition at a Global Clock pin. The DCM is in use. No Input Delay is programmed.	LVCMOS25(2), IFD_DELAY_VALUE = 0, with DCM(4)	XC3S50A	2.45	2.68	ns
			XC3S200A	2.59	2.84	ns
			XC3S400A	2.38	2.68	ns
			XC3S700A	2.38	2.57	ns
			XC3S1400A	1.91	2.17	ns
T_{PSFD}	When writing to IFF, the time from the setup of data at the Input pin to an active transition at the Global Clock pin. The DCM is not in use. The Input Delay is programmed.	LVCMOS25(2), IFD_DELAY_VALUE = 5, without DCM	XC3S50A	2.55	2.76	ns
			XC3S200A	2.32	2.76	ns
			XC3S400A	2.21	2.60	ns
			XC3S700A	2.28	2.63	ns
			XC3S1400A	2.33	2.41	ns
Hold Times						
T_{PHDCM}	When writing to IFF, the time from the active transition at the Global Clock pin to the point when data must be held at the Input pin. The DCM is in use. No Input Delay is programmed.	LVCMOS25(3), IFD_DELAY_VALUE = 0, with DCM(4)	XC3S50A	-0.36	-0.36	ns
			XC3S200A	-0.52	-0.52	ns
			XC3S400A	-0.33	-0.29	ns
			XC3S700A	-0.17	-0.12	ns
			XC3S1400A	-0.07	0.00	ns
T_{PHFD}	When writing to IFF, the time from the active transition at the Global Clock pin to the point when data must be held at the Input pin. The DCM is not in use. The Input Delay is programmed.	LVCMOS25(3), IFD_DELAY_VALUE = 5, without DCM	XC3S50A	-0.63	-0.58	ns
			XC3S200A	-0.56	-0.56	ns
			XC3S400A	-0.42	-0.42	ns
			XC3S700A	-0.80	-0.75	ns
			XC3S1400A	-0.69	-0.69	ns

Notes:

1. The numbers in this table are tested using the methodology presented in Table 27 and are based on the operating conditions set forth in Table 8 and Table 11.
2. This setup time requires adjustment whenever a signal standard other than LVCMOS25 is assigned to the Global Clock Input or the data Input. If this is true of the Global Clock Input, subtract the appropriate adjustment from Table 23. If this is true of the data Input, add the appropriate Input adjustment from the same table.
3. This hold time requires adjustment whenever a signal standard other than LVCMOS25 is assigned to the Global Clock Input or the data Input. If this is true of the Global Clock Input, add the appropriate Input adjustment from Table 23. If this is true of the data Input, subtract the appropriate Input adjustment from the same table. When the hold time is negative, it is possible to change the data before the clock's active edge.
4. DCM output jitter is included in all measurements.

Input Propagation Times

Table 22: **Propagation Times for the IOB Input Path**

Symbol	Description	Conditions	DELAY_VALUE	Device	Speed Grade -5 Max	Speed Grade -4 Max	Units
Propagation Times							
T_{IOPI}	The time it takes for data to travel from the Input pin to the I output with no input delay programmed	LVCMOS25[2]	IBUF_DELAY_VALUE=0	XC3S50A	1.04	1.12	ns
				XC3S200A	0.87	0.87	ns
				XC3S400A	0.65	0.72	ns
				XC3S700A	0.92	0.92	ns
				XC3S1400A	0.96	1.21	ns
T_{IOPID}	The time it takes for data to travel from the Input pin to the I output with the input delay programmed	LVCMOS25[2]	1	XC3S50A	1.79	2.07	ns
			2		2.13	2.46	ns
			3		2.36	2.71	ns
			4		2.88	3.21	ns
			5		3.11	3.46	ns
			6		3.45	3.84	ns
			7		3.75	4.19	ns
			8		4.00	4.47	ns
			9		3.61	4.11	ns
			10		3.95	4.50	ns
			11		4.18	4.67	ns
			12		4.75	5.20	ns
			13		4.98	5.44	ns
			14		5.31	5.95	ns
			15		5.62	6.28	ns
			16		5.86	6.57	ns
			1	XC3S200A	1.57	1.65	ns
			2		1.87	1.97	ns
			3		2.16	2.33	ns
			4		2.68	2.96	ns
			5		2.87	3.19	ns
			6		3.20	3.60	ns
			7		3.57	4.02	ns
			8		3.79	4.26	ns
			9		3.42	3.86	ns
			10		3.79	4.25	ns
			11		4.02	4.55	ns
			12		4.62	5.24	ns
			13		4.86	5.53	ns
			14		5.18	5.94	ns

Output Propagation Times

Table 24: **Timing for the IOB Output Path**

Symbol	Description	Conditions	Device	Speed Grade -5 Max	Speed Grade -4 Max	Units
Clock-to-Output Times						
T_{IOCKP}	When reading from the Output Flip-Flop (OFF), the time from the active transition at the OCLK input to data appearing at the Output pin	LVCMOS25(2), 12 mA output drive, Fast slew rate	All	2.87	3.13	ns
Propagation Times						
T_{IOOP}	The time it takes for data to travel from the IOB's O input to the Output pin	LVCMOS25(2), 12 mA output drive, Fast slew rate	All	2.78	2.91	ns
Set/Reset Times						
T_{IOSRP}	Time from asserting the OFF's SR input to setting/resetting data at the Output pin	LVCMOS25(2), 12 mA output drive, Fast slew rate	All	3.63	3.89	ns
T_{IOGSRQ}	Time from asserting the Global Set Reset (GSR) input on the STARTUP_SPARTAN3A primitive to setting/resetting data at the Output pin			8.62	9.65	ns

Notes:

1. The numbers in this table are tested using the methodology presented in Table 27 and are based on the operating conditions set forth in Table 8 and Table 11.
2. This time requires adjustment whenever a signal standard other than LVCMOS25 with 12 mA drive and Fast slew rate is assigned to the data Output. When this is true, *add* the appropriate Output adjustment from Table 26.

Three-State Output Propagation Times

Table 25: **Timing for the IOB Three-State Path**

Symbol	Description	Conditions	Device	Speed Grade -5 Max	Speed Grade -4 Max	Units
Synchronous Output Enable/Disable Times						
T_{IOCKHZ}	Time from the active transition at the OTCLK input of the Three-state Flip-Flop (TFF) to when the Output pin enters the high-impedance state	LVCMOS25, 12 mA output drive, Fast slew rate	All	0.63	0.76	ns
T_{IOCKON}(2)	Time from the active transition at TFF's OTCLK input to when the Output pin drives valid data		All	2.80	3.06	ns
Asynchronous Output Enable/Disable Times						
T_{GTS}	Time from asserting the Global Three State (GTS) input on the STARTUP_SPARTAN3A primitive to when the Output pin enters the high-impedance state	LVCMOS25, 12 mA output drive, Fast slew rate	All	9.47	10.36	ns
Set/Reset Times						
T_{IOSRHZ}	Time from asserting TFF's SR input to when the Output pin enters a high-impedance state	LVCMOS25, 12 mA output drive, Fast slew rate	All	1.61	1.86	ns
T_{IOSRON}(2)	Time from asserting TFF's SR input at TFF to when the Output pin drives valid data		All	3.57	3.82	ns

Notes:

1. The numbers in this table are tested using the methodology presented in Table 27 and are based on the operating conditions set forth in Table 8 and Table 11.
2. This time requires adjustment whenever a signal standard other than LVCMOS25 with 12 mA drive and Fast slew rate is assigned to the data Output. When this is true, *add* the appropriate Output adjustment from Table 26.

Using IBIS Models to Simulate Load Conditions in Application

IBIS models permit the most accurate prediction of timing delays for a given application. The parameters found in the IBIS model (V_{REF}, R_{REF}, and V_{MEAS}) correspond directly with the parameters used in Table 27 (V_T, R_T, and V_M). Do not confuse V_{REF} (the termination voltage) from the IBIS model with V_{REF} (the input-switching threshold) from the table. A fourth parameter, C_{REF}, is always zero. The four parameters describe all relevant output test conditions. IBIS models are found in the Xilinx development software as well as at the following link:

www.xilinx.com/support/download/index.htm

Delays for a given application are simulated according to its specific load conditions as follows:

1. Simulate the desired signal standard with the output driver connected to the test setup shown in Figure 9. Use parameter values V_T, R_T, and V_M from Table 27. C_{REF} is zero.
2. Record the time to V_M.
3. Simulate the same signal standard with the output driver connected to the PCB trace with load. Use the appropriate IBIS model (including V_{REF}, R_{REF}, C_{REF}, and V_{MEAS} values) or capacitive value to represent the load.
4. Record the time to V_{MEAS}.
5. Compare the results of steps 2 and 4. Add (or subtract) the increase (or decrease) in delay to (or from) the appropriate Output standard adjustment (Table 26) to yield the worst-case delay of the PCB trace.

Simultaneously Switching Output Guidelines

This section provides guidelines for the recommended maximum allowable number of Simultaneous Switching Outputs (SSOs). These guidelines describe the maximum number of user I/O pins of a given output signal standard that should simultaneously switch in the same direction, while maintaining a safe level of switching noise. Meeting these guidelines for the stated test conditions ensures that the FPGA operates free from the adverse effects of ground and power bounce.

Ground or power bounce occurs when a large number of outputs simultaneously switch in the same direction. The output drive transistors all conduct current to a common voltage rail. Low-to-High transitions conduct to the V_{CCO} rail; High-to-Low transitions conduct to the GND rail. The resulting cumulative current transient induces a voltage difference across the inductance that exists between the die pad and the power supply or ground return. The inductance is associated with bonding wires, the package lead frame, and any other signal routing inside the package. Other variables contribute to SSO noise levels, including stray inductance on the PCB as well as capacitive loading at receivers. Any SSO-induced voltage consequently affects internal switching noise margins and ultimately signal quality.

Table 28 and Table 29 provide the essential SSO guidelines. For each device/package combination, Table 28 provides the number of equivalent V_{CCO}/GND pairs. The equivalent number of pairs is based on characterization and may not match the physical number of pairs. For each output signal standard and drive strength, Table 29 recommends the maximum number of SSOs, switching in the same direction, allowed per V_{CCO}/GND pair within an I/O bank. The guidelines in Table 29 are categorized by package style, slew rate, and output drive current. Furthermore, the number of SSOs is specified by I/O bank. Generally, the left and right I/O banks (Banks 1 and 3) support higher output drive current.

Multiply the appropriate numbers from Table 28 and Table 29 to calculate the maximum number of SSOs allowed within an I/O bank. Exceeding these SSO guidelines might result in increased power or ground bounce, degraded signal integrity, or increased system jitter.

SSO_{MAX}/IO Bank = Table 28 x Table 29

The recommended maximum SSO values assume that the FPGA is soldered on the printed circuit board and that the board uses sound design practices. The SSO values do not apply for FPGAs mounted in sockets, due to the lead inductance introduced by the socket.

The SSO values assume that the V_{CCAUX} is powered at 3.3V. Setting V_{CCAUX} to 2.5V provides better SSO characteristics.

The number of SSOs allowed for quad-flat packages (VQ/TQ) is lower than for ball grid array packages (FG) due to the larger lead inductance of the quad-flat packages. Ball grid array packages are recommended for applications with a large number of simultaneously switching outputs.

Configurable Logic Block (CLB) Timing

Table 30: **CLB (SLICEM) Timing**

Symbol	Description	Speed Grade				Units
		-5		-4		
		Min	Max	Min	Max	
Clock-to-Output Times						
T_{CKO}	When reading from the FFX (FFY) Flip-Flop, the time from the active transition at the CLK input to data appearing at the XQ (YQ) output	–	0.60	–	0.68	ns
Setup Times						
T_{AS}	Time from the setup of data at the F or G input to the active transition at the CLK input of the CLB	0.18	–	0.36	–	ns
T_{DICK}	Time from the setup of data at the BX or BY input to the active transition at the CLK input of the CLB	1.58	–	1.88	–	ns
Hold Times						
T_{AH}	Time from the active transition at the CLK input to the point where data is last held at the F or G input	0	–	0	–	ns
T_{CKDI}	Time from the active transition at the CLK input to the point where data is last held at the BX or BY input	0	–	0	–	ns
Clock Timing						
T_{CH}	The High pulse width of the CLB's CLK signal	0.63	–	0.75	–	ns
T_{CL}	The Low pulse width of the CLK signal	0.63	–	0.75	–	ns
F_{TOG}	Toggle frequency (for export control)	0	770	0	667	MHz
Propagation Times						
T_{ILO}	The time it takes for data to travel from the CLB's F (G) input to the X (Y) output	–	0.62	–	0.71	ns
Set/Reset Pulse Width						
T_{RPW_CLB}	The minimum allowable pulse width, High or Low, to the CLB's SR input	1.33	–	1.61	–	ns

Notes:

1. The numbers in this table are based on the operating conditions set forth in Table 8.

Phase Shifter (PS)

Table 40: **Recommended Operating Conditions for the PS in Variable Phase Mode**

Symbol	Description	Speed Grade				Units
		-5		-4		
		Min	Max	Min	Max	
Operating Frequency Ranges						
PSCLK_FREQ (F_{PSCLK})	Frequency for the PSCLK input	1	167	1	167	MHz
Input Pulse Requirements						
PSCLK_PULSE	PSCLK pulse width as a percentage of the PSCLK period	40%	60%	40%	60%	-

Table 41: **Switching Characteristics for the PS in Variable Phase Mode**

Symbol	Description		Phase Shift Amount	Units
Phase Shifting Range				
MAX_STEPS(2)	Maximum allowed number of DCM_DELAY_STEP steps for a given CLKIN clock period, where T = CLKIN clock period in ns. If using CLKIN_DIVIDE_BY_2 = TRUE, double the clock effective clock period.	CLKIN < 60 MHz	±[INTEGER(10 • (T_{CLKIN} – 3 ns))]	steps
		CLKIN ≥ 60 MHz	±[INTEGER(15 • (T_{CLKIN} – 3 ns))]	
FINE_SHIFT_RANGE_MIN	Minimum guaranteed delay for variable phase shifting		±[MAX_STEPS • DCM_DELAY_STEP_MIN]	ns
FINE_SHIFT_RANGE_MAX	Maximum guaranteed delay for variable phase shifting		±[MAX_STEPS • DCM_DELAY_STEP_MAX]	ns

Notes:

1. The numbers in this table are based on the operating conditions set forth in Table 8 and Table 40.
2. The maximum variable phase shift range, MAX_STEPS, is only valid when the DCM is has no initial fixed phase shifting, that is, the PHASE_SHIFT attribute is set to 0.
3. The DCM_DELAY_STEP values are provided at the bottom of Table 37.

Configuration Clock (CCLK) Characteristics

Table 46: **Master Mode CCLK Output Period by *ConfigRate* Opti0on Setting**

Symbol	Description	***ConfigRate* Setting**	Temperature Range	Minimum	Maximum	Units
T_{CCLK1}	CCLK clock period by ***ConfigRate*** setting	1 *(power-on value)*	Commercial	1,254	2,500	ns
			Industrial	1,180		ns
T_{CCLK3}		3	Commercial	413	833	ns
			Industrial	390		ns
T_{CCLK6}		6 (default)	Commercial	207	417	ns
			Industrial	195		ns
T_{CCLK7}		7	Commercial	178	357	ns
			Industrial	168		ns
T_{CCLK8}		8	Commercial	156	313	ns
			Industrial	147		ns
T_{CCLK10}		10	Commercial	123	250	ns
			Industrial	116		ns
T_{CCLK12}		12	Commercial	103	208	ns
			Industrial	97		ns
T_{CCLK13}		13	Commercial	93	192	ns
			Industrial	88		ns
T_{CCLK17}		17	Commercial	72	147	ns
			Industrial	68		ns
T_{CCLK22}		22	Commercial	54	114	ns
			Industrial	51		ns
T_{CCLK25}		25	Commercial	47	100	ns
			Industrial	45		ns
T_{CCLK27}		27	Commercial	44	93	ns
			Industrial	42		ns
T_{CCLK33}		33	Commercial	36	76	ns
			Industrial	34		ns
T_{CCLK44}		44	Commercial	26	57	ns
			Industrial	25		ns
T_{CCLK50}		50	Commercial	22	50	ns
			Industrial	21		ns
$T_{CCLK100}$		100	Commercial	11.2	25	ns
			Industrial	10.6		ns

Notes:

1. Set the ***ConfigRate*** option value when generating a configuration bitstream.

IEEE 1149.1/1532 JTAG Test Access Port Timing

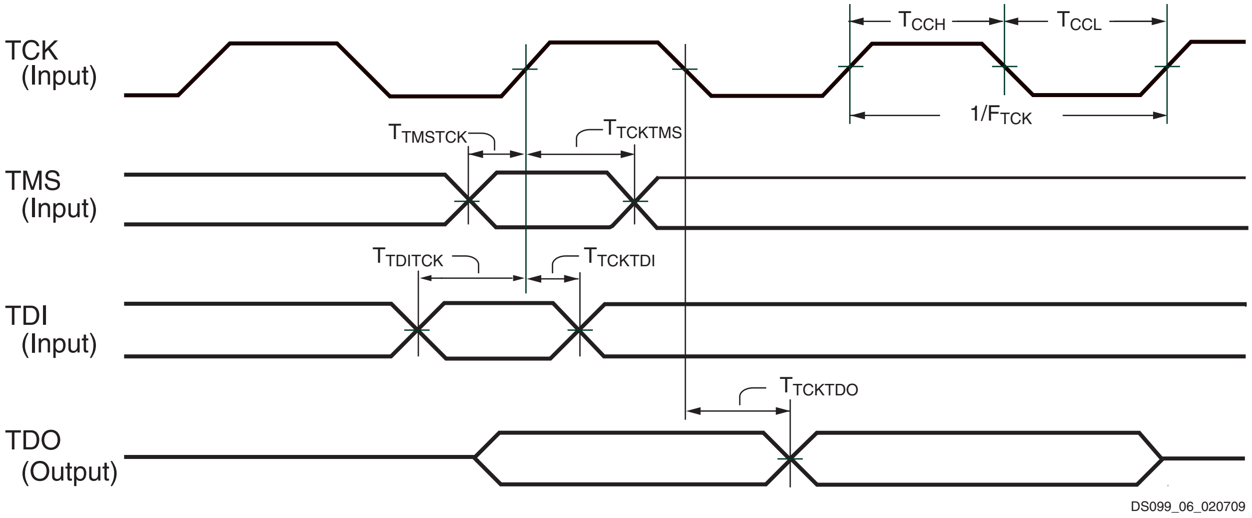


Figure 16: **JTAG Waveforms**

Table 56: **Timing for the JTAG Test Access Port**

Symbol	Description		All Speed Grades		Units
			Min	Max	
Clock-to-Output Times					
T_{TCKTDO}	The time from the falling transition on the TCK pin to data appearing at the TDO pin		1.0	11.0	ns
Setup Times					
T_{TDITCK}	The time from the setup of data at the TDI pin to the rising transition at the TCK pin	All devices and functions except those shown below	7.0	–	ns
		Boundary scan commands (INTEST, EXTEST, SAMPLE) on XC3S700A and XC3S1400A FPGAs	11.0		
T_{TMSTCK}	The time from the setup of a logic level at the TMS pin to the rising transition at the TCK pin		7.0	–	ns
Hold Times					
T_{TCKTDI}	The time from the rising transition at the TCK pin to the point when data is last held at the TDI pin	All functions except those shown below	0	–	ns
		Configuration commands (CFG_IN, ISC_PROGRAM)	2.0		
T_{TCKTMS}	The time from the rising transition at the TCK pin to the point when a logic level is last held at the TMS pin		0	–	ns
Clock Timing					
T_{CCH}	The High pulse width at the TCK pin	All functions except ISC_DNA command	5	–	ns
T_{CCL}	The Low pulse width at the TCK pin		5	–	ns
T_{CCHDNA}	The High pulse width at the TCK pin	During ISC_DNA command	10	10,000	ns
T_{CCLDNA}	The Low pulse width at the TCK pin		10	10,000	ns
F_{TCK}	Frequency of the TCK signal	All operations on XC3S50A, XC3S200A, and XC3S400A FPGAs and for BYPASS or HIGHZ instructions on all FPGAs	0	33	MHz
		All operations on XC3S700A and XC3S1400A FPGAs, except for BYPASS or HIGHZ instructions		20	

Notes:

1. The numbers in this table are based on the operating conditions set forth in Table 8.
2. For details on JTAG see Chapter 9 "JTAG Configuration Mode and Boundary-Scan" in UG332 *Spartan-3 Generation Configuration User Guide*.

Revision History

The following table shows the revision history for this document.

Date	Version	Revision
12/05/06	1.0	Initial release.
02/02/07	1.1	Promoted to Preliminary status. Moved Table 15 to under "DC Electrical Characteristics" section. Updated all timing specifications for the v1.32 speed files. Added recommended Simultaneous Switching Output (SSO) limits in Table 29. Set a 10 µs maximum pulse width for the DNA_PORT READ signal and the JTAG clock input during the ISC_DNA command, affecting both Table 43 and Table 56. Described "External Termination Requirements for Differential I/O." Added separate DIN hold time for Slave mode in Table 50. Corrected wording in Table 52 and Table 54; no specifications affected.
03/16/07	1.2	Updated all AC timing specifications to the v1.34 speeds file. Promoted the XC3S700A and XC3S1400A FPGAs offered in the -4 speed grade to Production status, as shown in Table 16. Added Note 2 to Table 39 regarding the extra logic (one LUT) automatically added by ISE 9.1i and later software revisions for any DCM application that leverages the Digital Frequency Synthesizer (DFS). Separated some JTAG specifications by array size or function, as shown in Table 56. Updated quiescent current limits in Table 10.
04/23/07	1.3	Updated all AC timing specifications to the v1.35 speeds file. Promoted all devices except the XC3S400A to Production status, as shown in Table 16.
05/08/07	1.4	Updated XC3S400A to Production and v1.36 speeds file. Added banking rules and other explanatory footnotes to Table 12 and Table 13. Corrected DIFF_SSTL3_II V_{OL} Max in Table 14. Improved XC3S400A Pin-to-Pin Clock-to-Output times in Table 18. Updated XC3S400A Pin-to-Pin Setup Times in Table 19. Updated TIOICKPD for -5 in Table 20. Added SSO numbers to Table 28 and Table 29. Removed invalid Embedded Multiplier Hold Times in Table 34. Improved CLKOUT_FREQ_CLK90 in Table 37. Improved T_{TDITCK} and F_{TCK} performance for XC3S400A in Table 56.
07/10/07	1.5	Added DIFF_HSTL_I and DIFF_HSTL_III to Table 13, Table 14, Table 27, and Table 29. Updated TMDS DC characteristics in Table 14. Updated for speed file v1.37 in ISE 9.2.01i as shown in Table 17. Updated pin-to-pin setup and hold times in Table 19. Updated TMDS output adjustment in Table 26. Updated I/O Test Method values in Table 27. Added BLVDS SSO numbers inTable 29. For Multiplier block, updated setup times and added hold times to Table 34. Updated block RAM clock width in Table 35. Updated CLKOUT_PER_JITT_2X and CLKOUT_PER_JITT_DV2 in Table 37. Added CCLK specifications for Commercial in Table 46 through Table 48.
04/15/08	1.6	Added V_{IN} to Recommended Operating Conditions in Table 8 and added reference to XAPP459, "Eliminating I/O Coupling Effects when Interfacing Large-Swing Single-Ended Signals to User I/O Pins." Reduced typical I_{CCINTQ} and I_{CCAUXQ} quiescent current values by 12%-58% in Table 10. Increased V_{IL} max to 0.4V for LVCMOS12/15/18 and improved V_{IH} min to 0.7V for LVCMOS12 in Table 11. Changed V_{OL} max to 0.4V and V_{OH} min to V_{CCO}-0.4V for LVCMOS15/18 in Table 12. Noted latest speed file v1.39 in ISE 10.1 software in Table 16. Added new packages to SSO limits in Table 28 and Table 29. Improved SSTL18_II SSO limit for FG packages in Table 29. Improved F_{BUFG} for -4 to 334 MHz in Table 33. Added references to 375 MHz performance via SCD 4103 in Table 33,Table 38, Table 39, and Table 40. Restored Units column to Table 44. Updated CCLK output maximum period in Table 46 to match minimum frequency in Table 47. Corrected BPI active clock edge in Figure 15 and Table 54.
05/28/08	1.7	Improved V_{CCAUXT} and V_{CCO2T} POR minimum in Table 5 and updated V_{CCO} POR levels in Figure 11. Clarified recommended V_{IN} in Table 8. Added reference to V_{CCAUX} in "Simultaneously Switching Output Guidelines". Added reference to Sample Window in Table 21. Removed DNA_RETENTION limit of 10 years in Table 15 since number of Read cycles is the only unique limit. Added references to UG332.
03/06/09	1.8	Changed typical quiescent current temperature from ambient to junction. Updated BPI configuration waveforms in Figure 15 and updated Table 55. Updated selected I/O standard DC characteristics. Added TIOPI and TIOPID in Table 22. Removed references to SCD 4103.
08/19/10	2.0	Added I_{IK} to Table 4. Updated V_{IN} in Table 8 and footnoted I_L in Table 9 to note potential leakage between pins of a differential pair. Clarified LVPECL notes to Table 13. Corrected symbols for TSUSPEND_GTS and TSUSPEND_GWE in Table 44.

Package Thermal Characteristics

The power dissipated by an FPGA application has implications on package selection and system design. The power consumed by a Spartan-3A FPGA is reported using either the XPower Power Estimator or the XPower Analyzer calculator integrated in the Xilinx® ISE® development software. Table 62 provides the thermal characteristics for the various Spartan-3A FPGA package offerings. This information is also available using the Thermal Query tool on xilinx.com (www.xilinx.com/cgi-bin/thermal/thermal.pl).

The junction-to-case thermal resistance (θ_{JC}) indicates the difference between the temperature measured on the package body (case) and the die junction temperature per watt of power consumption. The junction-to-board (θ_{JB}) value similarly reports the difference between the board and junction temperature. The junction-to-ambient (θ_{JA}) value reports the temperature difference between the ambient environment and the junction temperature. The θ_{JA} value is reported at different air velocities, measured in linear feet per minute (LFM). The “Still Air (0 LFM)” column shows the θ_{JA} value in a system without a fan. The thermal resistance drops with increasing air flow.

Table 62: **Spartan-3A Package Thermal Characteristics**

Package	Device	Junction-to-Case (θ_{JC})	Junction-to-Board (θ_{JB})	Junction-to-Ambient (θ_{JA}) at Different Air Flows				Units
				Still Air (0 LFM)	250 LFM	500 LFM	750 LFM	
VQ100 VQG100	XC3S50A	12.9	30.1	48.5	40.4	37.6	36.6	°C/Watt
	XC3S200A	10.9	25.7	42.9	35.7	33.2	32.4	°C/Watt
TQ144 TQG144	XC3S50A	16.5	32.0	42.4	36.3	35.8	34.9	°C/Watt
FT256 FTG256	XC3S50A	16.0	33.5	42.3	35.6	35.5	34.5	°C/Watt
	XC3S200A	10.3	23.8	32.7	26.6	26.1	25.2	°C/Watt
	XC3S400A	8.4	19.3	29.9	24.9	23.0	22.3	°C/Watt
	XC3S700A	7.8	18.6	28.1	22.3	21.2	20.7	°C/Watt
	XC3S1400A	5.4	14.1	24.2	18.7	17.5	17.0	°C/Watt
FG320 FGG320	XC3S200A	11.7	18.5	27.8	22.3	21.1	20.3	°C/Watt
	XC3S400A	9.9	15.4	25.2	19.8	18.6	17.8	°C/Watt
FG400 FGG400	XC3S400A	9.8	15.5	25.6	19.2	18.0	17.3	°C/Watt
	XC3S700A	8.2	13.0	23.1	17.9	16.7	16.0	°C/Watt
FG484 FGG484	XC3S700A	7.9	12.8	22.3	17.4	16.2	15.5	°C/Watt
	XC3S1400A	6.0	9.9	19.5	14.7	13.5	12.8	°C/Watt
FG676 FGG676	XC3S1400A	5.8	9.4	17.8	13.5	12.4	11.8	°C/Watt

VQ100: 100-lead Very Thin Quad Flat Package

The XC3S50A and XC3S200 are available in the 100-lead very thin quad flat package, VQ100.

Table 63 lists all the package pins. They are sorted by bank number and then by pin name. Pins that form a differential I/O pair appear together in the table. The table also shows the pin number for each pin and the pin type, as defined earlier.

The VQ100 does not support Suspend mode (SUSPEND and AWAKE are not connected), the address output pins for the Byte-wide Peripheral Interface (BPI) configuration mode, or daisy chain configuration (DOUT is not connected).

Table 63 also indicates that some differential I/O pairs have different assignments between the XC3S50A and the XC3S200A, highlighted in light blue. See "Footprint Migration Differences," page 72 for additional information.

An electronic version of this package pinout table and footprint diagram is available for download from the Xilinx website at

> www.xilinx.com/support/documentation/data_sheets/s3a_pin.zip.

Pinout Table

Table 63: **Spartan-3A VQ100 Pinout**

Bank	Pin Name	Pin	Type
0	IO_0/GCLK11	P90	CLK
0	IO_L01N_0	P78	IO
0	IO_L01P_0/VREF_0	P77	VREF
0	IO_L02N_0/GCLK5	P84	CLK
0	IO_L02P_0/GCLK4	P83	CLK
0	IO_L03N_0/GCLK7	P86	CLK
0	IO_L03P_0/GCLK6	P85	CLK
0	IO_L04N_0/GCLK9	P89	CLK
0	IO_L04P_0/GCLK8	P88	CLK
0	IO_L05N_0	P94	IO
0	IO_L05P_0	P93	IO
0	IO_L06N_0/PUDC_B	P99	DUAL
0	IO_L06P_0/VREF_0	P98	VREF
0	IP_0	P97	IP
0	IP_0/VREF_0	P82	VREF
0	VCCO_0	P79	VCCO
0	VCCO_0	P96	VCCO
1	IO_L01N_1	P57	IO
1	IO_L01P_1	P56	IO
1	IO_L02N_1/RHCLK1	P60	CLK
1	IO_L02P_1/RHCLK0	P59	CLK
1	IO_L03N_1/TRDY1/RHCLK3	P62	CLK
1	IO_L03P_1/RHCLK2	P61	CLK
1	IO_L04N_1/RHCLK7	P65	CLK
1	IO_L04P_1/IRDY1/RHCLK6	P64	CLK
1	IO_L05N_1	P71	IO
1	IO_L05P_1	P70	IO
1	IO_L06N_1	P73	IO
1	IO_L06P_1	P72	IO
1	IP_1/VREF_1	P68	VREF
1	VCCO_1	P67	VCCO
2	IO_2/MOSI/CSI_B	P46	DUAL
2	IO_L01N_2/M0	P25	DUAL
2	IO_L01P_2/M1	P23	DUAL
2	IO_L02N_2/CSO_B	P27	DUAL
2	IO_L02P_2/M2	P24	DUAL
2	IO_L03N_2/VS1 (3S50A) IO_L04P_2/VS1 (3S200A)	P30	DUAL
2	IO_L03P_2/RDWR_B	P28	DUAL
2	IO_L04N_2/VS0	P31	DUAL
2	IO_L04P_2/VS2 (3S50A) IO_L03N_2/VS2 (3S200A)	P29	DUAL
2	IO_L05N_2/D7 (3S50A) IO_L06P_2/D7 (3S200A)	P34	DUAL
2	IO_L05P_2	P32	IO
2	IO_L06N_2/D6	P35	DUAL
2	IO_L06P_2 (3S50A) IO_L05N_2 (3S200A)	P33	IO
2	IO_L07N_2/D4	P37	DUAL
2	IO_L07P_2/D5	P36	DUAL
2	IO_L08N_2/GCLK15	P41	CLK
2	IO_L08P_2/GCLK14	P40	CLK
2	IO_L09N_2/GCLK1	P44	CLK
2	IO_L09P_2/GCLK0	P43	CLK
2	IO_L10N_2/D3	P49	DUAL
2	IO_L10P_2/INIT_B	P48	DUAL
2	IO_L11N_2/D0/DIN/MISO (3S50A) IO_L12P_2/D0/DIN/MISO (3S200A)	P51	DUAL
2	IO_L11P_2/D2	P50	DUAL
2	IO_L12N_2/CCLK	P53	DUAL

Table 77: **Spartan-3A FG320 Pinout *(Continued)***

Bank	Pin Name	FG320 Ball	Type
3	IO_L10N_3/VREF_3	F1	VREF
3	IO_L10P_3	F2	I/O
3	IO_L11N_3	J6	I/O
3	IO_L11P_3	J7	I/O
3	IO_L13N_3	H1	I/O
3	IO_L13P_3	H2	I/O
3	IO_L14N_3/LHCLK1	J3	LHCLK
3	IO_L14P_3/LHCLK0	H3	LHCLK
3	IO_L15N_3/IRDY2/LHCLK3	J1	LHCLK
3	IO_L15P_3/LHCLK2	J2	LHCLK
3	IO_L17N_3/LHCLK5	K5	LHCLK
3	IO_L17P_3/LHCLK4	J4	LHCLK
3	IO_L18N_3/LHCLK7	K3	LHCLK
3	IO_L18P_3/TRDY2/LHCLK6	K2	LHCLK
3	IO_L19N_3	L2	I/O
3	IO_L19P_3/VREF_3	L1	VREF
3	IO_L21N_3	M2	I/O
3	IO_L21P_3	N1	I/O
3	IO_L22N_3	N2	I/O
3	IO_L22P_3	P1	I/O
3	IO_L23N_3	L4	I/O
3	IO_L23P_3	L3	I/O
3	IO_L25N_3	R2	I/O
3	IO_L25P_3	R1	I/O
3	IO_L26N_3	N4	I/O
3	IO_L26P_3	N3	I/O
3	IO_L27N_3	T2	I/O
3	IO_L27P_3	T1	I/O
3	IO_L29N_3	N6	I/O
3	IO_L29P_3	N5	I/O
3	IO_L30N_3	R3	I/O
3	IO_L30P_3	P3	I/O
3	IO_L31N_3	U2	I/O
3	IO_L31P_3	U1	I/O
3	IP_L04N_3/VREF_3	H7	VREF
3	IP_L04P_3	G6	INPUT
3	IP_L08N_3/VREF_3	H5	VREF
3	IP_L08P_3	H6	INPUT
3	IP_L12N_3	G2	INPUT
3	IP_L12P_3	G3	INPUT

Table 77: **Spartan-3A FG320 Pinout *(Continued)***

Bank	Pin Name	FG320 Ball	Type
3	IP_L16N_3	K6	INPUT
3	IP_L16P_3	J5	INPUT
3	IP_L20N_3	L6	INPUT
3	IP_L20P_3	L7	INPUT
3	IP_L24N_3	M4	INPUT
3	IP_L24P_3	M3	INPUT
3	IP_L28N_3	M5	INPUT
3	IP_L28P_3	M6	INPUT
3	IP_L32N_3/VREF_3	P4	VREF
3	IP_L32P_3	P5	INPUT
3	VCCO_3	E2	VCCO
3	VCCO_3	H4	VCCO
3	VCCO_3	L5	VCCO
3	VCCO_3	P2	VCCO
GND	GND	A1	GND
GND	GND	A7	GND
GND	GND	A12	GND
GND	GND	A18	GND
GND	GND	C10	GND
GND	GND	D4	GND
GND	GND	D7	GND
GND	GND	D15	GND
GND	GND	F6	GND
GND	GND	G1	GND
GND	GND	G12	GND
GND	GND	G18	GND
GND	GND	H8	GND
GND	GND	H10	GND
GND	GND	J11	GND
GND	GND	J15	GND
GND	GND	K4	GND
GND	GND	K8	GND
GND	GND	L9	GND
GND	GND	L11	GND
GND	GND	M1	GND
GND	GND	M7	GND
GND	GND	M18	GND
GND	GND	N13	GND
GND	GND	R4	GND
GND	GND	R12	GND

Table 81: **Spartan-3A FG400 Pinout *(Continued)***

Bank	Pin Name	FG400 Ball	Type
1	IP_1/VREF_1	N14	VREF
1	IP_L04N_1/VREF_1	P15	VREF
1	IP_L04P_1	P14	INPUT
1	IP_L11N_1/VREF_1	M15	VREF
1	IP_L11P_1	M16	INPUT
1	IP_L15N_1	M13	INPUT
1	IP_L15P_1/VREF_1	M14	VREF
1	IP_L19N_1	L13	INPUT
1	IP_L19P_1	L14	INPUT
1	IP_L23N_1	K14	INPUT
1	IP_L23P_1/VREF_1	K15	VREF
1	IP_L27N_1	J15	INPUT
1	IP_L27P_1	J16	INPUT
1	IP_L31N_1	J13	INPUT
1	IP_L31P_1/VREF_1	J14	VREF
1	IP_L35N_1	H14	INPUT
1	IP_L35P_1	H15	INPUT
1	IP_L39N_1	G14	INPUT
1	IP_L39P_1/VREF_1	G15	VREF
1	VCCO_1	D19	VCCO
1	VCCO_1	H16	VCCO
1	VCCO_1	K19	VCCO
1	VCCO_1	N16	VCCO
1	VCCO_1	T19	VCCO
2	IO_L01N_2/M0	V4	DUAL
2	IO_L01P_2/M1	U4	DUAL
2	IO_L02N_2/CSO_B	Y2	DUAL
2	IO_L02P_2/M2	W3	DUAL
2	IO_L03N_2	W4	I/O
2	IO_L03P_2	Y3	I/O
2	IO_L04N_2	R7	I/O
2	IO_L04P_2	T6	I/O
2	IO_L05N_2	U5	I/O
2	IO_L05P_2	V5	I/O
2	IO_L06N_2	U6	I/O
2	IO_L06P_2	T7	I/O
2	IO_L07N_2/VS2	U7	DUAL
2	IO_L07P_2/RDWR_B	T8	DUAL
2	IO_L08N_2	Y5	I/O
2	IO_L08P_2	Y4	I/O
2	IO_L09N_2/VS0	W6	DUAL
2	IO_L09P_2/VS1	V6	DUAL
2	IO_L10N_2	Y7	I/O
2	IO_L10P_2	Y6	I/O
2	IO_L11N_2	U9	I/O
2	IO_L11P_2	T9	I/O
2	IO_L12N_2/D6	W8	DUAL
2	IO_L12P_2/D7	V7	DUAL
2	IO_L13N_2	V9	I/O
2	IO_L13P_2	V8	I/O
2	IO_L14N_2/D4	T10	DUAL
2	IO_L14P_2/D5	U10	DUAL
2	IO_L15N_2/GCLK13	Y9	GCLK
2	IO_L15P_2/GCLK12	W9	GCLK
2	IO_L16N_2/GCLK15	W10	GCLK
2	IO_L16P_2/GCLK14	V10	GCLK
2	IO_L17N_2/GCLK1	V11	GCLK
2	IO_L17P_2/GCLK0	Y11	GCLK
2	IO_L18N_2/GCLK3	V12	GCLK
2	IO_L18P_2/GCLK2	U11	GCLK
2	IO_L19N_2	R12	I/O
2	IO_L19P_2	T12	I/O
2	IO_L20N_2/MOSI/CSI_B	W12	DUAL
2	IO_L20P_2	Y12	I/O
2	IO_L21N_2	W13	I/O
2	IO_L21P_2	Y13	I/O
2	IO_L22N_2/DOUT	V13	DUAL
2	IO_L22P_2/AWAKE	U13	PWR MGMT
2	IO_L23N_2	R13	I/O
2	IO_L23P_2	T13	I/O
2	IO_L24N_2/D3	W14	DUAL
2	IO_L24P_2/INIT_B	Y14	DUAL
2	IO_L25N_2	T14	I/O
2	IO_L25P_2	V14	I/O
2	IO_L26N_2/D1	V15	DUAL
2	IO_L26P_2/D2	Y15	DUAL
2	IO_L27N_2	T15	I/O
2	IO_L27P_2	U15	I/O
2	IO_L28N_2	W16	I/O

Table 81: **Spartan-3A FG400 Pinout*(Continued)***

Bank	Pin Name	FG400 Ball	Type
2	IO_L28P_2	Y16	I/O
2	IO_L29N_2	U16	I/O
2	IO_L29P_2	V16	I/O
2	IO_L30N_2	Y18	I/O
2	IO_L30P_2	Y17	I/O
2	IO_L31N_2	U17	I/O
2	IO_L31P_2	V17	I/O
2	IO_L32N_2/CCLK	Y19	DUAL
2	IO_L32P_2/D0/DIN/MISO	W18	DUAL
2	IP_2	P9	INPUT
2	IP_2	P12	INPUT
2	IP_2	P13	INPUT
2	IP_2	R8	INPUT
2	IP_2	R10	INPUT
2	IP_2	T11	INPUT
2	IP_2/VREF_2	N9	VREF
2	IP_2/VREF_2	N12	VREF
2	IP_2/VREF_2	P8	VREF
2	IP_2/VREF_2	P10	VREF
2	IP_2/VREF_2	P11	VREF
2	IP_2/VREF_2	R14	VREF
2	VCCO_2	R11	VCCO
2	VCCO_2	U8	VCCO
2	VCCO_2	U14	VCCO
2	VCCO_2	W5	VCCO
2	VCCO_2	W11	VCCO
2	VCCO_2	W17	VCCO
3	IO_L01N_3	D3	I/O
3	IO_L01P_3	D4	I/O
3	IO_L02N_3	C2	I/O
3	IO_L02P_3	B1	I/O
3	IO_L03N_3	D2	I/O
3	IO_L03P_3	C1	I/O
3	IO_L05N_3	E1	I/O
3	IO_L05P_3	D1	I/O
3	IO_L06N_3	G5	I/O
3	IO_L06P_3	F4	I/O
3	IO_L07N_3	J5	I/O
3	IO_L07P_3	J6	I/O
3	IO_L08N_3	H4	I/O

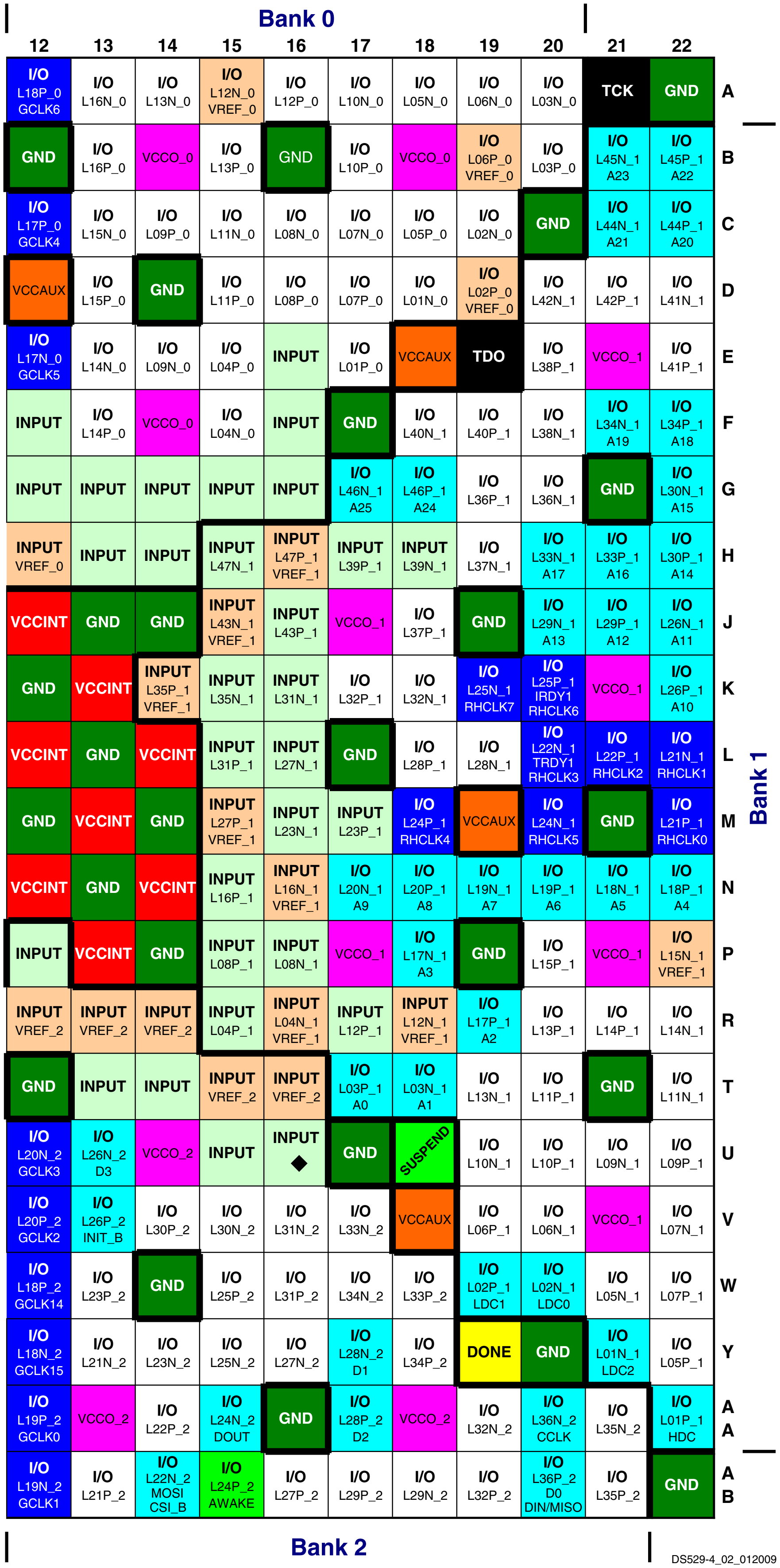
Table 81: **Spartan-3A FG400 Pinout*(Continued)***

Bank	Pin Name	FG400 Ball	Type
3	IO_L08P_3	H6	I/O
3	IO_L09N_3	G4	I/O
3	IO_L09P_3	F3	I/O
3	IO_L10N_3	F2	I/O
3	IO_L10P_3	E3	I/O
3	IO_L12N_3	H2	I/O
3	IO_L12P_3	G3	I/O
3	IO_L13N_3/VREF_3	G1	VREF
3	IO_L13P_3	F1	I/O
3	IO_L14N_3	H3	I/O
3	IO_L14P_3	J4	I/O
3	IO_L16N_3	J2	I/O
3	IO_L16P_3	J3	I/O
3	IO_L17N_3/LHCLK1	K2	LHCLK
3	IO_L17P_3/LHCLK0	J1	LHCLK
3	IO_L18N_3/IRDY2/LHCLK3	L3	LHCLK
3	IO_L18P_3/LHCLK2	K3	LHCLK
3	IO_L20N_3/LHCLK5	L5	LHCLK
3	IO_L20P_3/LHCLK4	K4	LHCLK
3	IO_L21N_3/LHCLK7	M1	LHCLK
3	IO_L21P_3/TRDY2/LHCLK6	L1	LHCLK
3	IO_L22N_3	M3	I/O
3	IO_L22P_3/VREF_3	M2	VREF
3	IO_L24N_3	M5	I/O
3	IO_L24P_3	M4	I/O
3	IO_L25N_3	N2	I/O
3	IO_L25P_3	N1	I/O
3	IO_L26N_3	N4	I/O
3	IO_L26P_3	N3	I/O
3	IO_L28N_3	R1	I/O
3	IO_L28P_3	P1	I/O
3	IO_L29N_3	P4	I/O
3	IO_L29P_3	P3	I/O
3	IO_L30N_3	R3	I/O
3	IO_L30P_3	R2	I/O
3	IO_L32N_3	T2	I/O
3	IO_L32P_3/VREF_3	T1	VREF
3	IO_L33N_3	R4	I/O
3	IO_L33P_3	T3	I/O
3	IO_L34N_3	U3	I/O

Table 83: **Spartan-3A FG484 Pinout*(Continued)***

Bank	Pin Name	FG484 Ball	Type
VCCAUX	DONE	Y19	CONFIG
VCCAUX	PROG_B	C4	CONFIG
VCCAUX	TCK	A21	JTAG
VCCAUX	TDI	F5	JTAG
VCCAUX	TDO	E19	JTAG
VCCAUX	TMS	D4	JTAG
VCCAUX	VCCAUX	D12	VCCAUX
VCCAUX	VCCAUX	E18	VCCAUX
VCCAUX	VCCAUX	E5	VCCAUX
VCCAUX	VCCAUX	H11	VCCAUX
VCCAUX	VCCAUX	L4	VCCAUX
VCCAUX	VCCAUX	M19	VCCAUX
VCCAUX	VCCAUX	P11	VCCAUX
VCCAUX	VCCAUX	V18	VCCAUX
VCCAUX	VCCAUX	V5	VCCAUX
VCCAUX	VCCAUX	W11	VCCAUX
VCCINT	VCCINT	J10	VCCINT
VCCINT	VCCINT	J12	VCCINT
VCCINT	VCCINT	K11	VCCINT
VCCINT	VCCINT	K13	VCCINT
VCCINT	VCCINT	K9	VCCINT
VCCINT	VCCINT	L10	VCCINT
VCCINT	VCCINT	L12	VCCINT
VCCINT	VCCINT	L14	VCCINT
VCCINT	VCCINT	M11	VCCINT
VCCINT	VCCINT	M13	VCCINT
VCCINT	VCCINT	M9	VCCINT
VCCINT	VCCINT	N10	VCCINT
VCCINT	VCCINT	N12	VCCINT
VCCINT	VCCINT	N14	VCCINT
VCCINT	VCCINT	P13	VCCINT

Right Half of FG484 Package (Top View)



	12	13	14	15	16	17	18	19	20	21	22
A	I/O L18P_0 GCLK6	I/O L16N_0	I/O L13N_0	I/O L12N_0 VREF_0	I/O L12P_0	I/O L10N_0	I/O L05N_0	I/O L06N_0	I/O L03N_0	TCK	GND
B	GND	I/O L16P_0	VCCO_0	I/O L13P_0	GND	I/O L10P_0	VCCO_0	I/O L06P_0 VREF_0	I/O L03P_0	I/O L45N_1 A23	I/O L45P_1 A22
C	I/O L17P_0 GCLK4	I/O L15N_0	I/O L09P_0	I/O L11N_0	I/O L08N_0	I/O L07N_0	I/O L05P_0	I/O L02N_0	GND	I/O L44N_1 A21	I/O L44P_1 A20
D	VCCAUX	I/O L15P_0	GND	I/O L11P_0	I/O L08P_0	I/O L07P_0	I/O L01N_0	I/O L02P_0 VREF_0	I/O L42N_1	I/O L42P_1	I/O L41N_1
E	I/O L17N_0 GCLK5	I/O L14N_0	I/O L09N_0	I/O L04P_0	INPUT	I/O L01P_0	VCCAUX	TDO	I/O L38P_1	VCCO_1	I/O L41P_1
F	INPUT	I/O L14P_0	VCCO_0	I/O L04N_0	INPUT	GND	I/O L40N_1	I/O L40P_1	I/O L38N_1	I/O L34N_1 A19	I/O L34P_1 A18
G	INPUT	INPUT	INPUT	INPUT	INPUT	I/O L46N_1 A25	I/O L46P_1 A24	I/O L36P_1	I/O L36N_1	GND	I/O L30N_1 A15
H	INPUT VREF_0	INPUT	INPUT	INPUT L47N_1	INPUT L47P_1 VREF_1	INPUT L39P_1	INPUT L39N_1	I/O L37N_1	I/O L33N_1 A17	I/O L33P_1 A16	I/O L30P_1 A14
J	VCCINT	GND	GND	INPUT L43N_1 VREF_1	INPUT L43P_1	VCCO_1	I/O L37P_1	GND	I/O L29N_1 A13	I/O L29P_1 A12	I/O L26N_1 A11
K	GND	VCCINT	INPUT L35P_1 VREF_1	INPUT L35N_1	INPUT L31N_1	I/O L32P_1	I/O L32N_1	I/O L25N_1 RHCLK7	I/O L25P_1 IRDY1 RHCLK6	VCCO_1	I/O L26P_1 A10
L	VCCINT	GND	VCCINT	INPUT L31P_1	INPUT L27N_1	GND	I/O L28P_1	I/O L28N_1	I/O L22N_1 TRDY1 RHCLK3	I/O L22P_1 RHCLK2	I/O L21N_1 RHCLK1
M	GND	VCCINT	GND	INPUT L27P_1 VREF_1	INPUT L23N_1	INPUT L23P_1	I/O L24P_1 RHCLK4	VCCAUX	I/O L24N_1 RHCLK5	GND	I/O L21P_1 RHCLK0
N	VCCINT	GND	VCCINT	INPUT L16P_1	INPUT L16N_1 VREF_1	I/O L20N_1 A9	I/O L20P_1 A8	I/O L19N_1 A7	I/O L19P_1 A6	I/O L18N_1 A5	I/O L18P_1 A4
P	INPUT	VCCINT	GND	INPUT L08P_1	INPUT L08N_1	VCCO_1	I/O L17N_1 A3	GND	I/O L15P_1	VCCO_1	I/O L15N_1 VREF_1
R	INPUT VREF_2	INPUT VREF_2	INPUT VREF_2	INPUT L04P_1	INPUT L04N_1 VREF_1	INPUT L12P_1	INPUT L12N_1 VREF_1	I/O L17P_1 A2	I/O L13P_1	I/O L14P_1	I/O L14N_1
T	GND	INPUT	INPUT	INPUT VREF_2	INPUT VREF_2	I/O L03P_1 A0	I/O L03N_1 A1	I/O L13N_1	I/O L11P_1	GND	I/O L11N_1
U	I/O L20N_2 GCLK3	I/O L26N_2 D3	VCCO_2	INPUT	INPUT ◆	GND	SUSPEND	I/O L10N_1	I/O L10P_1	I/O L09N_1	I/O L09P_1
V	I/O L20P_2 GCLK2	I/O L26P_2 INIT_B	I/O L30P_2	I/O L30N_2	I/O L31N_2	I/O L33N_2	VCCAUX	I/O L06P_1	I/O L06N_1	VCCO_1	I/O L07N_1
W	I/O L18P_2 GCLK14	I/O L23P_2	GND	I/O L25P_2	I/O L31P_2	I/O L34N_2	I/O L33P_2	I/O L02P_1 LDC1	I/O L02N_1 LDC0	I/O L05N_1	I/O L07P_1
Y	I/O L18N_2 GCLK15	I/O L21N_2	I/O L23N_2	I/O L25N_2	I/O L27N_2	I/O L28N_2 D1	I/O L34P_2	DONE	GND	I/O L01N_1 LDC2	I/O L05P_1
AA	I/O L19P_2 GCLK0	VCCO_2	I/O L22P_2	I/O L24N_2 DOUT	GND	I/O L28P_2 D2	VCCO_2	I/O L32N_2	I/O L36N_2 CCLK	I/O L35N_2	I/O L01P_1 HDC
AB	I/O L19N_2 GCLK1	I/O L21P_2	I/O L22N_2 MOSI CSI_B	I/O L24P_2 AWAKE	I/O L27P_2	I/O L29P_2	I/O L29N_2	I/O L32P_2	I/O L36P_2 D0 DIN/MISO	I/O L35P_2	GND

Figure 26:

Table 87: **Spartan-3A FG676 Pinout*(Continued)***

Bank	Pin Name	FG676 Ball	Type
1	IO_L03P_1/A0	AC23	DUAL
1	IO_L04N_1	W21	I/O
1	IO_L04P_1	W20	I/O
1	IO_L05N_1	AC25	I/O
1	IO_L05P_1	AD26	I/O
1	IO_L06N_1	AB26	I/O
1	IO_L06P_1	AC26	I/O
1	IO_L07N_1/VREF_1	AB24	VREF
1	IO_L07P_1	AB23	I/O
1	IO_L08N_1	V19	I/O
1	IO_L08P_1	V18	I/O
1	IO_L09N_1	AA23	I/O
1	IO_L09P_1	AA22	I/O
1	IO_L10N_1	U20	I/O
1	IO_L10P_1	V21	I/O
1	IO_L11N_1	AA25	I/O
1	IO_L11P_1	AA24	I/O
1	IO_L12N_1	U18	I/O
1	IO_L12P_1	U19	I/O
1	IO_L13N_1	Y23	I/O
1	IO_L13P_1	Y22	I/O
1	IO_L14N_1	T20	I/O
1	IO_L14P_1	U21	I/O
1	IO_L15N_1	Y25	I/O
1	IO_L15P_1	Y24	I/O
1	IO_L17N_1	T17	I/O
1	IO_L17P_1	T18	I/O
1	IO_L18N_1	V22	I/O
1	IO_L18P_1	W23	I/O
1	IO_L19N_1	V25	I/O
1	IO_L19P_1	V24	I/O
1	IO_L21N_1	U22	I/O
1	IO_L21P_1	V23	I/O
1	IO_L22N_1	R20	I/O
1	IO_L22P_1	R19	I/O
1	IO_L23N_1/VREF_1	U24	VREF
1	IO_L23P_1	U23	I/O
1	IO_L25N_1/A3	R22	DUAL
1	IO_L25P_1/A2	R21	DUAL
1	IO_L26N_1/A5	T24	DUAL

Table 87: **Spartan-3A FG676 Pinout*(Continued)***

Bank	Pin Name	FG676 Ball	Type
1	IO_L26P_1/A4	T23	DUAL
1	IO_L27N_1/A7	R17	DUAL
1	IO_L27P_1/A6	R18	DUAL
1	IO_L29N_1/A9	R26	DUAL
1	IO_L29P_1/A8	R25	DUAL
1	IO_L30N_1/RHCLK1	P20	RHCLK
1	IO_L30P_1/RHCLK0	P21	RHCLK
1	IO_L31N_1/TRDY1/RHCLK3	P25	RHCLK
1	IO_L31P_1/RHCLK2	P26	RHCLK
1	IO_L33N_1/RHCLK5	N24	RHCLK
1	IO_L33P_1/RHCLK4	P23	RHCLK
1	IO_L34N_1/RHCLK7	N19	RHCLK
1	IO_L34P_1/IRDY1/RHCLK6	P18	RHCLK
1	IO_L35N_1/A11	M25	DUAL
1	IO_L35P_1/A10	M26	DUAL
1	IO_L37N_1	N21	I/O
1	IO_L37P_1	P22	I/O
1	IO_L38N_1/A13	M23	DUAL
1	IO_L38P_1/A12	L24	DUAL
1	IO_L39N_1/A15	N17	DUAL
1	IO_L39P_1/A14	N18	DUAL
1	IO_L41N_1	K26	I/O
1	IO_L41P_1	K25	I/O
1	IO_L42N_1/A17	M20	DUAL
1	IO_L42P_1/A16	N20	DUAL
1	IO_L43N_1/A19	J25	DUAL
1	IO_L43P_1/A18	J26	DUAL
1	IO_L45N_1	M22	I/O
1	IO_L45P_1	M21	I/O
1	IO_L46N_1	K22	I/O
1	IO_L46P_1	K23	I/O
1	IO_L47N_1	M18	I/O
1	IO_L47P_1	M19	I/O
1	IO_L49N_1	J22	I/O
1	IO_L49P_1	J23	I/O
1	IO_L50N_1	K21	I/O
1	IO_L50P_1	L22	I/O
1	IO_L51N_1	G24	I/O
1	IO_L51P_1	G23	I/O
1	IO_L53N_1	K20	I/O

Right Half of FG676 Package (Top View)

14	15	16	17	18	19	20	21	22	23	24	25	26	
I/O L26N_0 GCLK7	I/O L23N_0	GND	INPUT	I/O L18N_0	I/O L15N_0	I/O L14N_0	GND	I/O L07N_0	INPUT	N.C. ◆	TCK	GND	A
I/O L26P_0 GCLK6	I/O L23P_0	VCCO_0	I/O L19N_0	I/O L18P_0	I/O L15P_0	I/O L14P_0 VREF_0	I/O L09N_0	VCCO_0	I/O L07P_0	N.C. ◆	INPUT L65N_1	INPUT L65P_1 VREF_1	B
GND	I/O L22N_0	I/O L21N_0	I/O L19P_0	I/O L17N_0	GND	I/O L11N_0	I/O L09P_0	I/O L05N_0	I/O L06N_0	GND	I/O L63N_1 A23	I/O L63P_1 A22	C
INPUT VREF_0	INPUT	I/O L22P_0	I/O L21P_0	I/O L17P_0	INPUT	I/O L11P_0	I/O L10N_0	I/O L05P_0	I/O L06P_0	I/O L61N_1	I/O L61P_1	I/O L60N_1	D
I/O L24P_0	I/O L20N_0 VREF_0	VCCAUX	I/O L13N_0	INPUT	VCCO_0	INPUT	I/O L10P_0	VCCAUX	TDO	I/O L56P_1	VCCO_1	I/O L60P_1	E
I/O L24N_0	I/O L20P_0	GND	I/O L13P_0	N.C. ◆	I/O L02N_0	I/O L01N_0	GND	I/O L58P_1 VREF_1	I/O L56N_1	I/O L54N_1	I/O L54P_1	GND	F
INPUT	I/O L16P_0	INPUT	I/O L08N_0	N.C. ◆	I/O L02P_0 VREF_0	I/O L01P_0	I/O L64N_1 A25	I/O L58N_1	I/O L51P_1	I/O L51N_1	INPUT L52N_1 VREF_1	INPUT L52P_1	G
GND	I/O L16N_0	VCCO_0	I/O L08P_0	INPUT	GND	I/O L64P_1 A24	I/O L62N_1 A21	VCCO_1	INPUT L48P_1	INPUT L48N_1	INPUT L44N_1	INPUT L44P_1 VREF_1	H
I/O L25N_0 GCLK5	INPUT	I/O L12P_0	INPUT VREF_0	VCCAUX	I/O L59P_1	I/O L59N_1	I/O L62P_1 A20	I/O L49N_1	I/O L49P_1	GND	I/O L43N_1 A19	I/O L43P_1 A18	J
I/O L25P_0 GCLK4	VCCINT	I/O L12N_0	GND	I/O L57N_1	I/O L57P_1	I/O L53N_1	I/O L50N_1	I/O L46N_1	I/O L46P_1	INPUT L40P_1	I/O L41P_1	I/O L41N_1	K
VCCINT	GND	VCCINT	I/O L55N_1	I/O L55P_1	VCCO_1	I/O L53P_1	GND	I/O L50P_1	INPUT L40N_1	I/O L38P_1 A12	VCCO_1	GND	L
GND	VCCINT	GND	VCCINT	I/O L47N_1	I/O L47P_1	I/O L42N_1 A17	I/O L45P_1	I/O L45N_1	I/O L38N_1 A13	INPUT L36P_1 VREF_1	I/O L35N_1 A11	I/O L35P_1 A10	M
VCCINT	GND	VCCINT	I/O L39N_1 A15	I/O L39P_1 A14	I/O L34N_1 RHCLK7	I/O L42P_1 A16	I/O L37N_1	VCCO_1	INPUT L36N_1	I/O L33N_1 RHCLK5	INPUT L32N_1	INPUT L32P_1	N
VCCINT	VCCINT	GND	VCCAUX	I/O L34P_1 IRDY1 RHCLK6	GND	I/O L30N_1 RHCLK1	I/O L30P_1 RHCLK0	I/O L37P_1	I/O L33P_1 RHCLK4	GND	I/O L31N_1 TRDY1 RHCLK3	I/O L31P_1 RHCLK2	P
VCCINT	GND	VCCINT	I/O L27N_1 A7	I/O L27P_1 A6	I/O L22P_1	I/O L22N_1	I/O L25P_1 A2	I/O L25N_1 A3	INPUT L28P_1 VREF_1	INPUT L28N_1	I/O L29P_1 A8	I/O L29N_1 A9	R
GND	VCCINT	GND	I/O L17N_1	I/O L17P_1	VCCO_1	I/O L14N_1	GND	VCCAUX	I/O L26P_1 A4	I/O L26N_1 A5	VCCO_1	GND	T
VCCAUX	I/O L35N_2	I/O L42N_2	GND	I/O L12N_1	I/O L12P_1	I/O L10N_1	I/O L14P_1	I/O L21N_1	I/O L23P_1	I/O L23N_1 VREF_1	INPUT L24P_1	INPUT L24N_1 VREF_1	U
I/O L31P_2	I/O L35P_2	I/O L42P_2	I/O L46N_2	I/O L08P_1	I/O L08N_1	SUSPEND	I/O L10P_1	I/O L18N_1	I/O L21P_1	I/O L19P_1	I/O L19N_1	INPUT L20N_1 VREF_1	V
GND	I/O L31N_2	VCCO_2	I/O L46P_2	N.C. ◆	GND	I/O L04P_1	I/O L04N_1	VCCO_1	I/O L18P_1	GND	INPUT L16P_1	INPUT L20P_1	W
I/O L27P_2 GCLK0	I/O L34N_2 D3	INPUT 2 VREF_2	I/O L43N_2	N.C. ◆	N.C. ◆	I/O L01P_1 HDC	I/O L01N_1 LDC2	I/O L13P_1	I/O L13N_1	I/O L15P_1	I/O L15N_1	INPUT L16N_1	Y
I/O L27N_2 GCLK1	I/O L34P_2 INIT_B	GND	I/O L43P_2	I/O L47N_2	INPUT	INPUT VREF_2	GND	I/O L09P_1	I/O L09N_1	I/O L11P_1	I/O L11N_1	GND	AA
VCCO_2	I/O L30N_2 MOSI CSI_B	I/O L38N_2	INPUT	I/O L47P_2	VCCO_2	INPUT	DONE	VCCAUX	I/O L07P_1	I/O L07N_1 VREF_1	VCCO_1	I/O L06N_1	AB
I/O L29N_2	I/O L30P_2	I/O L38P_2	INPUT	INPUT	I/O L40N_2	I/O L41N_2	I/O L45N_2	N.C. ◆	I/O L03P_1 A0	I/O L03N_1 A1	I/O L05N_1	I/O L06P_1	AC
I/O L29P_2	I/O L32P_2 AWAKE	INPUT	I/O L33N_2	GND	I/O L40P_2	I/O L41P_2	I/O L44N_2	I/O L45P_2	N.C. ◆	GND	I/O L02N_1 LDC0	I/O L05P_1	AD
I/O L28N_2 GCLK3	I/O L32N_2 DOUT	VCCO_2	I/O L33P_2	I/O L36N_2 D1	I/O L37N_2	I/O L39N_2	I/O L44P_2	VCCO_2	I/O L48N_2	I/O L52N_2 CCLK	I/O L51N_2	I/O L02P_1 LDC1	AE
I/O L28P_2 GCLK2	INPUT VREF_2	GND	INPUT VREF_2	I/O L36P_2 D2	I/O L37P_2	I/O L39P_2	GND	INPUT VREF_2	I/O L48P_2	I/O L52P_2 D0 DIN/MISO	I/O L51P_2	GND	AF